

Application Data Sheet

Application Information

Application Type:: Regular
Subject Matter:: Utility
Title:: CRITICAL DIMENSION MEASURING
INSTRUMENT
Total Drawing Sheets:: 4
Formal Drawings:: Yes
Attorney Docket Number:: 5005.1062

Applicant Information

Inventor One Given Name:: Franz
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City of Residence:: Weilmuenster
State or Country of Residence:: Germany
Postal or Zip Code:: 35789
Citizenship Country:: Germany

Inventor Two Given Name:: Lambert
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Representative Information

Representative Customer Number:: 23280

Domestic Priority Information

| Application:: | Continuity Type:: | Parent Application:: | Parent Filing Date:: |
|---------------|-------------------|----------------------|----------------------|
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Foreign Priority Information

| Country:: | Application number:: | Filing Date:: | Priority Claimed:: |
|-----------|----------------------|---------------|--------------------|
| Germany | DE 102 45 473.6 | 09/28/2002 | Yes |
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Assignee Information

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|---|---------------------------------------|
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